



深圳市诚芯微科技有限公司

SHENZHEN CHENGXINWEI TECHNOLOGY CO.,LTD

CX8507

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## General Description

The CX8507 is a single-phase, constant-on-time, synchronous PWM controller, which drives N-channel MOSFETs. The CX8507 steps down high voltage to generate low-voltage chipset or RAM supplies in notebook computers.

The CX8507 provides excellent transient response and accurate DC voltage output in either PFM or PWM Mode. In Pulse Frequency Mode (PFM), the CX8507 provides very high efficiency over light to heavy loads with loading-modulated switching frequencies. In PWM Mode, the converter works nearly at constant frequency for low-noise requirements.

The CX8507 is equipped with accurate positive current-limit, output under-voltage, and output over-voltage protections, perfect for NB applications. The Power-On-Reset function monitors the voltage on VCC to prevent wrong operation during power-on. The CX8507 has a 1ms digital soft-start and built-in an integrated output discharge method for soft-stop. An internal integrated soft-start ramps up the output voltage with programmable slew rate to reduce the start-up current. A soft-stop function actively discharges the output capacitors with controlled reverse inductor current.

The CX8507 is available in 10pin TDFN 3x3 package.

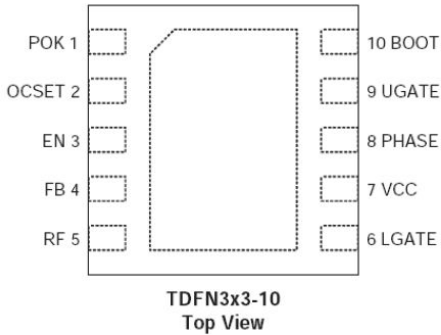
## Features

- Adjustable Output Voltage from +0.7V to +5.5V
- 0.7V Reference Voltage
- $\pm 1\%$  Accuracy Over-Temperature
- Operates from an Input Battery Voltage Range of +1.8V to +32V
- Power-On-Reset Monitoring on VCC Pin
- Excellent Line and Load Transient Responses
- PFM Mode for Increased Light Load Efficiency
- Selectable PWM Frequency from 4 Preset Values
- Integrated MOSFET Drivers
- Integrated Bootstrap Forward P-CH MOSFET
- Adjustable Integrated Soft-Start and Soft-Stop
- Selectable Forced PWM or Automatic PFM/PWM Mode
- Power Good Monitoring
- 70% Under-Voltage Protection
- 125% Over-Voltage Protection
- Adjustable Current-Limit Protection
- Using Sense Low-Side MOSFET's  $R_{DS(ON)}$
- Over-Temperature Protection
- TDFN-10 3x3 Package
- Lead Free and Green Devices Available (RoHS Compliant)

## Applications

- Notebook
- Table PC
- Hand-Held Portable
- AIO PC
- LCD Monitor / TV
- Battery Charger
- ADSL Modem
- Telecom / Networking Equipment

# Pin Assignments



= GND and Thermal Pad (connected to GND plane for better heat dissipation)

PIN		NAME	FUNCTION
NO.			
TDFN3x3	TDFN2x2		
1	1	POK	Power Good Output. POK is an open drain output used to indicate the status of the output voltage. Connect the POK in to +5V through a pull-high resistor.
2	2	OCSET	Current-Limit Threshold Setting Pin. There is an internal source current 10 uA through a resistor from OCSET pin to GND. This pin is used to monitor the voltage drop across the Drain and Source of the low-side MOSFET for current-limit.
3	3	EN	Enable Pin of The PWM Controller. When the EN is above enable logic level, the Device is workable. When the EN is below shutdown logic level, the device is in shutdown and only low leakage current is taken from VCC and VIN.
4	4	FB	Output Voltage Feedback Pin. This pin is connected to the resistive divider that set the desired output voltage. The POK, UVP, and OVP circuits detect this signal to report output voltage status.
5	-	RF	This Pin is Allowed to Adjust The Switching Frequency. Connect a resistor RRF to set switching frequency as show in Table1. The pin also controls forced PWM mode or PFM/PWM auto skip mode selection. When RF pin is pulled down to GND, the device is in automatic PFM/PWM Mode. When RF pin is pulled high to POK, the device is in force PWM mode.
6	6	LGATE	Output of The Low-side MOSFET Driver. Connect this pin to Gate of the low-side MOSFET. Swings from GND to VCC.
7	7	VCC	Supply Voltage Input Pin for Control Circuitry. Connect +5V from the VCC pin to the GND pin. Decoupling at least 1u F of a MLCC capacitor from the VCC pin to the GND pin.
8	8	PHASE	Junction Point of The High-side MOSFET Source, Output Filter Inductor and The Low-side MOSFET Drain. Connect this pin to the Source of the high-side MOSFET. PHASE serves as the lower supply rail for the UGATE high-side gate driver.
9	9	UGATE	Output of The High-side MOSFET Driver. Connect this pin to Gate of the high-side MOSFET.
10	10	BOOT	Supply Input for The UGATE Gate Driver and An Internal Level-shift Circuit. Connect to an external capacitor to create a boosted voltage suitable to drive a logic-level N-channel MOSFET.
Exposed Pad	5	GND	Signal Ground for The IC

## Ordering Information

CX8507 □ □

Circuit Type

Packing:

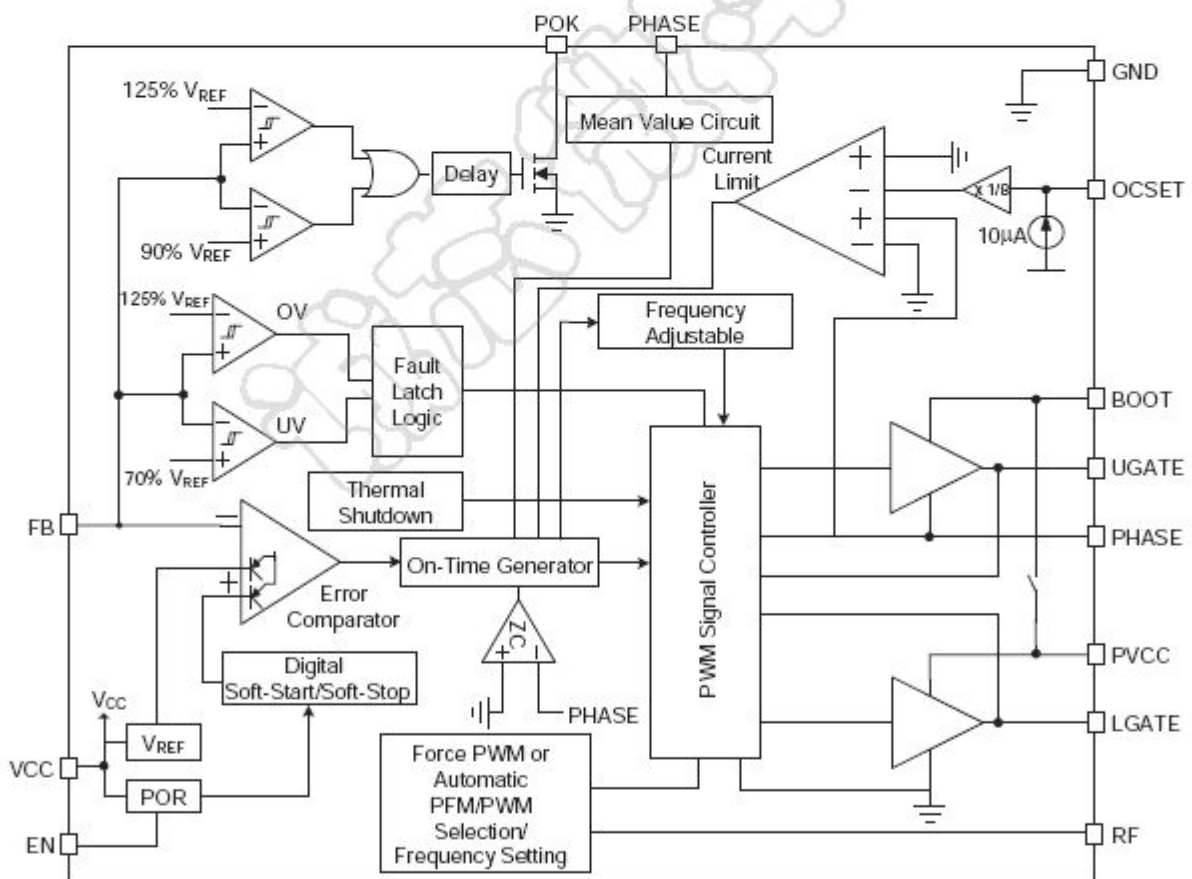
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R: Type and Reel

Package

Q:TDFN

## Functional Block Diagram



Functional Block Diagram of CX8507

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
$V_{CC}$	VCC Supply Voltage (VCC to GND)	-0.3 ~ 7	V
$V_{BOOT-GND}$	BOOT Supply Voltage (BOOT to GND)	-0.3 ~ 35	V
$V_{BOOT}$	BOOT Supply Voltage (BOOT to PHASE)	-0.3 ~ 7	V
	All Other Pins (POK, OCSET, EN, FB, and RF to GND)	-0.3 ~ $V_{CC}+0.3$	V
	UGATE Voltage (UGATE to PHASE)<400ns Pulse Width>400ns Pulse Width	-5 ~ $V_{BOOT}+0.3$ -0.3 ~ $V_{BOOT}+0.3$	V
	LGATE Voltage (LGATE to GND)<400ns Pulse Width>400ns Pulse Width	-5 ~ $V_{CC}+0.3$ -0.3 ~ $V_{CC}+0.3$	V
$V_{PHASE}$	PHASE Voltage (PHASE to GND)<400ns Pulse Width>400ns Pulse Width	-5 ~ 35 -1 ~ 32	V
$T_J$	Maximum Junction Temperature	150	°C
$T_{STG}$	Storage Temperature	-65 ~ 150	°C
$T_{SDR}$	Maximum Soldering Temperature, 10 Seconds	260	°C

Note: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

## Recommended Operating Conditions

Symbol	Parameter	Range	Unit
VCC	VCC Supply Voltage	4.5 ~ 5.5	V
$V_{OUT}$	Converter Output Voltage	0.7 ~ 5.5	V
$I_{OUT}$	Converter Output Current	6	A
$T_A$	Ambient Temperature	-40 ~ 85	°C
$T_J$	Junction Temperature	-40 ~ 125	°C

Note: Refer to the typical application circuit.

## Thermal Characteristics

Symbol	Parameter	Typical Value	Unit
$\theta_{JA}$	Thermal Resistance-Junction to Ambient 3mmx3mm TDFN-10	55	°C/W

Note:  $\theta_{JA}$  is measured with the component mounted on a high effective the thermal conductivity test board in free air. The exposed pad of package is soldered directly on the PCB.

# Electrical Characteristics

Refer to the typical application circuit. These specifications apply over  $V_{CC} = 12V$ ,  $T_A = -40^{\circ}C$  to  $85^{\circ}C$ , unless otherwise noted. Typical values are at  $T_A = 25^{\circ}C$ .

Symbol	Parameter	Test Conditions	CX8507			Unit
			Min.	Typ.	Max.	
<b>VOOUT AND VFB VOLTAGE</b>						
$V_{OUT}$	Output Voltage	Adjustable output range	0.7	-	5.5	V
$V_{REF}$	Reference Voltage		-	0.7	-	V
	Regulation Accuracy	$T_A = 25^{\circ}C$	-0.5	-	+0.5	%
		$T_A = 0^{\circ}C \sim 85^{\circ}C$	-0.8	-	+0.8	%
		$T_A = -40^{\circ}C \sim 85^{\circ}C$	-1.0	-	+1.0	%
$I_{FB}$	FB Input Bias Current	FB = 0.7V	-	0.02	0.1	$\mu A$
$T_{DIS}$	$V_{OUT}$ Discharge Time	EN low to FB = 0V	-	12	-	ms
<b>SUPPLY CURRENT</b>						
$I_{VCC}$	VCC Input Bias Current	VCC Current, PWM, EN = 5V, VFB = 0.735V, PHASE =	-	250	520	$\mu A$
$I_{VCC\_SHDN}$	VCC Shutdown Current	EN = GND, VCC = 5V	-	0	1	$\mu A$
<b>SWITCHING FREQUENCY AND SUTY AND INTERNAL SOFT-START</b>						
$F_{SW}$	Switching Frequency	$R_{RF} = 470k$ , $T_A = 25^{\circ}C$ , $V_{IN}=8V$ , $V_{OUT}=1.1V$ , $I_{OUT}=10A$	266	290	314	kHz
		$R_{RF} = 200k$ , $T_A = 25^{\circ}C$ , $V_{IN}=8V$ , $V_{OUT}=1.1V$ , $I_{OUT}=10A$	312	340	368	
		$R_{RF} = 100k$ , $T_A = 25^{\circ}C$ , $V_{IN}=8V$ , $V_{OUT}=1.1V$ , $I_{OUT}=10A$	349	380	411	
		$R_{RF} = 39k$ , $T_A = 25^{\circ}C$ , $V_{IN}=8V$ , $V_{OUT}=1.1V$ , $I_{OUT}=10A$	395	430	465	
$T_{ON(MIN)}$	Minimum On Time		80	110	140	ns
$T_{OFF(MIN)}$	Minimum Off Time	$V_{FB} = 0.65V$ , $V_{PHASE} = -0.1V$ , OCSET = OPEN	350	450	550	ns
$T_{SS}$	Internal Soft-Start Time	EN High to $V_{OUT}$ Regulation (95%)	0.7	1.0	1.3	ms
<b>GATE DRIVER</b>						
	UGATE Pull-Up Resistance	BOOT-UGATE = 0.5V	-	1.5	3	$\Omega$
	UGATE Sink Resistance	UGATE-PHASE = 0.5V	-	0.7	1.8	$\Omega$
	LGATE Pull-Up Resistance	PVCC-LGATE = 0.5V	-	1.0	2.2	$\Omega$
	LGATE Sink Resistance	LGATE-GND = 0.5V	-	0.5	1.2	$\Omega$
	UGATE to LGATE Dead-Time	UGATE falling to LGATE rising	-	20	-	ns
	LGATE to UGATE Dead-Time	LGATE falling to UGATE rising	-	20	-	ns
<b>BOOTSTRAP SWITCH</b>						
$V_F$	Ron	$V_{VCC} - V_{BOOT-GND}$ , $I_F = 10mA$	-	0.5	0.8	V
$I_R$	Reverse Leakage	$V_{BOOT-GND} = 30V$ , $V_{PHASE} = 25V$ , $V_{VCC} = 5V$	-	-	0.5	$\mu A$
<b>VCC POR THRESHOLD</b>						
$V_{VCC\_THR}$	Rising VSS POR Threshold		4.2	4.35	4.45	V
	VCC POR Hysteresis		-	100	-	mV
<b>CONTROL INPUTS</b>						
	EN Voltage Threshold	Enable	1.8	-	-	V
		Shutdown	-	-	0.5	V

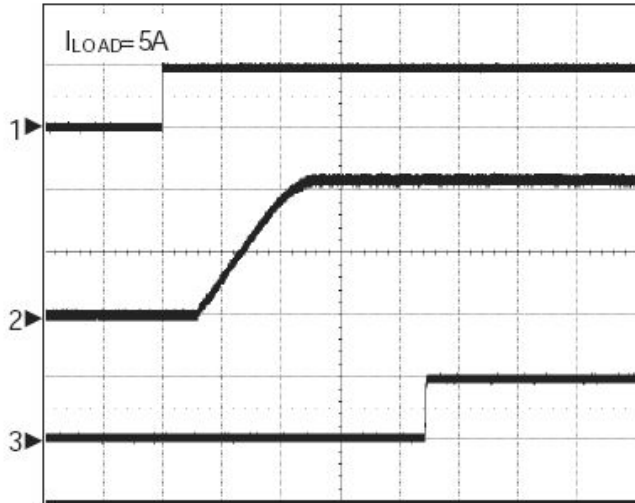
## Electrical Characteristics(Cont.)

Symbol	Parameter	Test Conditions	T			Unit
			Min.	Typ.	Max.	
<b>CONTROL INPUTS (CONT.)</b>						
	EN Leakage	EN = 0V	-	0.1	1.0	μA
	RF Setting Threshold	Forced PWM Mode	1.8	-	-	V
		PFM/PWM Auto Skip Mode	-	-	0.5	V
<b>POWER-OK INDICATOR</b>						
V <sub>POK</sub>	POK Threshold	POK in from Lower (POK Goes High)	87	90	93	%
		POK Low Hysteresis (POK Goes Low)	-	3	-	%
		POK out from Normal (POK Goes Low)	120	125	130	%
I <sub>POK</sub>	POK Leakage Current	V <sub>POK</sub> = 5V	-	0.1	1.0	μA
	POK Sink Current	V <sub>POK</sub> = 0.5V	2.5	7.5	-	mA
	POK Enable Delay Time	EN High to POK High	1.4	2.0	2.6	ms
<b>CURRENT SENSE</b>						
I <sub>OCSET</sub>	I <sub>OCSET</sub> OCP Threshold	I <sub>OCSET</sub> Sourcing	9	10	11	μA
T <sub>CIOCSET</sub>	I <sub>OCSET</sub> Temperature Coefficient	On The Basis of 25°C	-	4500	-	ppm/°
V <sub>ROCSET</sub>	Current-Limit Threshold Setting Range	V <sub>OCSET-GND</sub> Voltage, Over All Temperature	0.24	-	1.6	V
	Over Current-Limit	(V <sub>OCSET-GND</sub> -V <sub>GND-PHASE</sub> ) Voltage, V <sub>OCSET-GND</sub> =60mV	-10	0	10	mV
	Zero Crossing Comparator	V <sub>GND-PHASE</sub> Voltage, EN=3.3V	-9.5	0.5	10.5	mV
<b>PROTECTION</b>						
V <sub>UV</sub>	UVP Threshold		60	70	80	%
	UVP Hysteresis		-	3	-	%
	UVP Debounce Interval		-	16	-	us
	UVP Enable Delay	EN High to UVP Workable	1.4	2	2.6	ms
V <sub>OVR</sub>	OVP Rising Threshold		120	125	130	%
	OVP Propagation Delay	V <sub>FB</sub> Rising, DV=10mV	-	1.5	-	us
T <sub>QTR</sub>	OTP Rising Threshold (Note 4)		-	140	-	°C
	OTP Hysteresis (Note 4)		-	25	-	°C

Note : Guaranteed by design, not production tested.

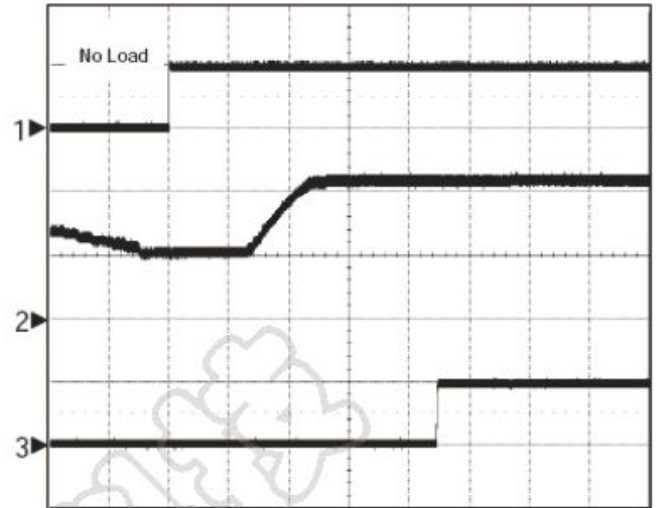
## Typical Operating Characteristics

Enable at Zero Initial Voltage of  $V_{OUT}$



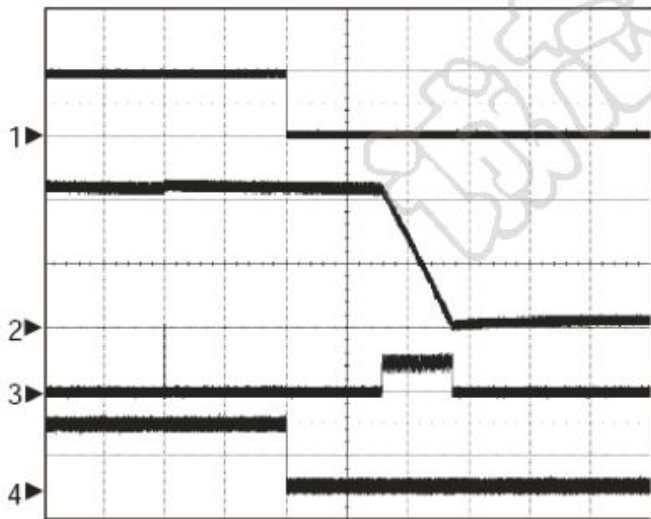
CH1:  $V_{EN}$ , 5V/Div, DC  
 CH2:  $V_{OUT}$ , 500mV/Div, DC  
 CH3:  $V_{POK}$ , 5V/Div, DC  
 TIME: 500 $\mu$ s/Div

Enable Before End of Soft-Stop



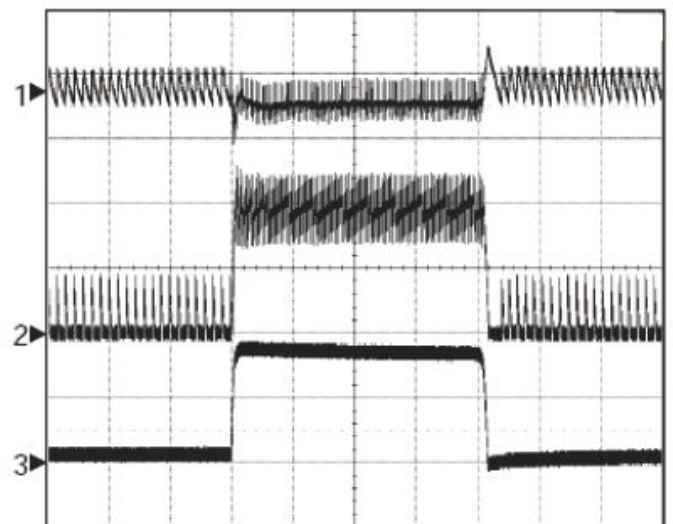
CH1:  $V_{EN}$ , 5V/Div, DC  
 CH2:  $V_{OUT}$ , 500mV/Div, DC  
 CH3:  $V_{POK}$ , 5V/Div, DC  
 TIME: 500 $\mu$ s/Div

Shutdown with Soft-Stop at No Load



CH1:  $V_{EN}$ , 5V/Div, DC  
 CH2:  $V_{OUT}$ , 500mV/Div, DC  
 CH3:  $V_{LGATE}$ , 5V/Div, DC  
 CH4:  $V_{POK}$ , 5V/Div, DC  
 TIME: 5ms/Div

$V_{OUT} = 1.1V$ , Load Transient 1A  $\rightarrow$  18A  $\rightarrow$  1A

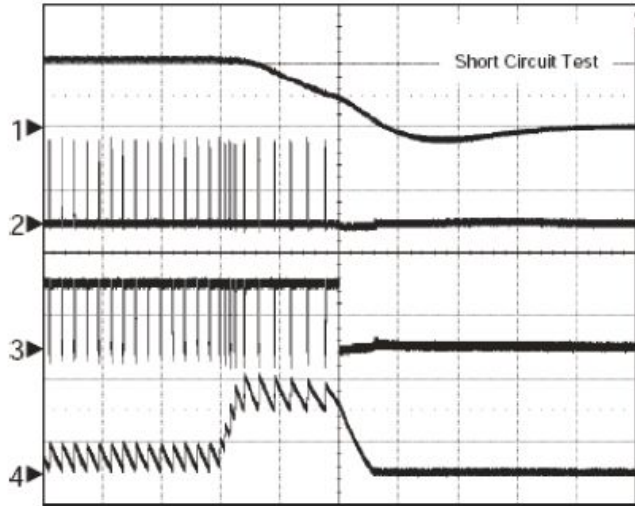


CH1:  $V_{OUT}$ , 50mV/Div, AC  
 CH2:  $I_L$ , 10A/Div, DC  
 CH3:  $I_{OUT}$ , 10A/Div, DC  
 TIME: 100 $\mu$ s/Div



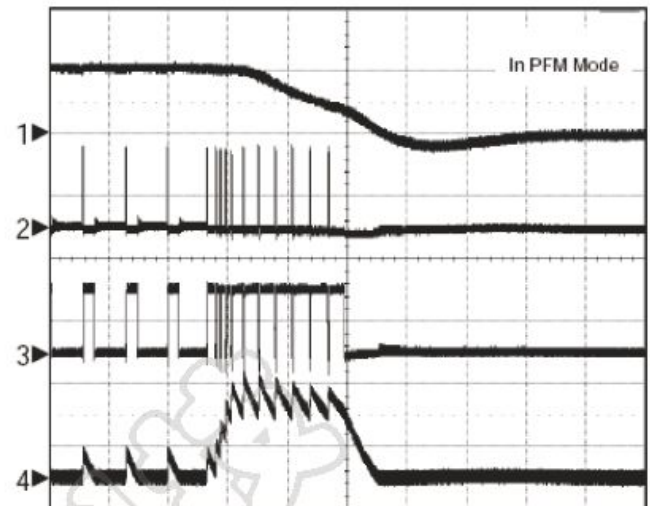
## Typical Operating Characteristics(Cont.)

### Under-Voltage Protection



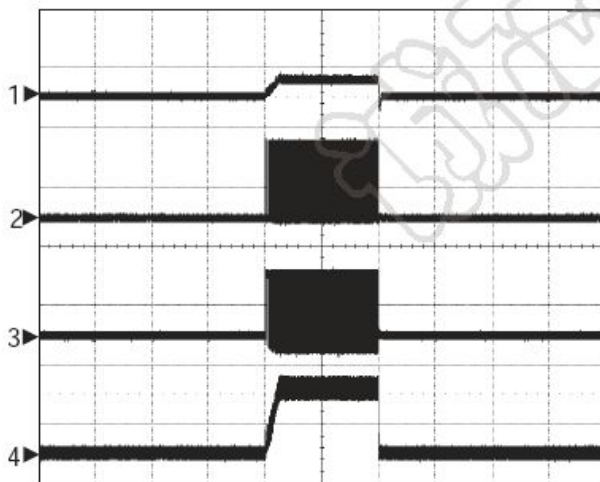
CH1:  $V_{OUT}$ , 1V/Div, DC  
 CH2:  $V_{UGATE}$ , 20V/Div, DC  
 CH3:  $V_{LGATE}$ , 5V/Div, DC  
 CH4:  $I_L$ , 20A/Div, DC  
 TIME: 20 $\mu$ s/Div

### Short Circuit Test



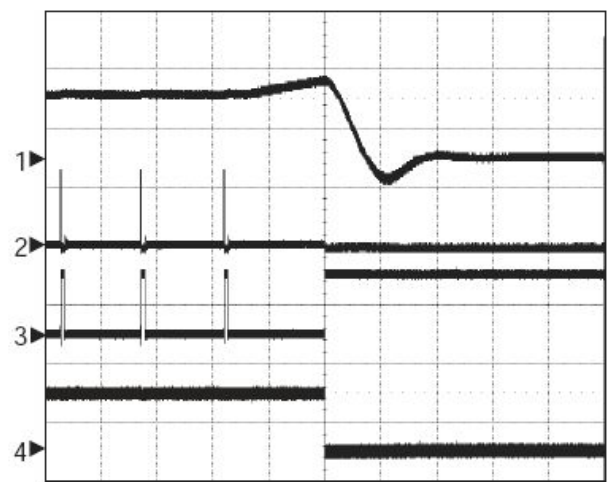
CH1:  $V_{OUT}$ , 1V/Div, DC  
 CH2:  $V_{UGATE}$ , 20V/Div, DC  
 CH3:  $V_{LGATE}$ , 5V/Div, DC  
 CH4:  $I_L$ , 20A/Div, DC  
 TIME: 20 $\mu$ s/Div

### Power On in Short Circuit



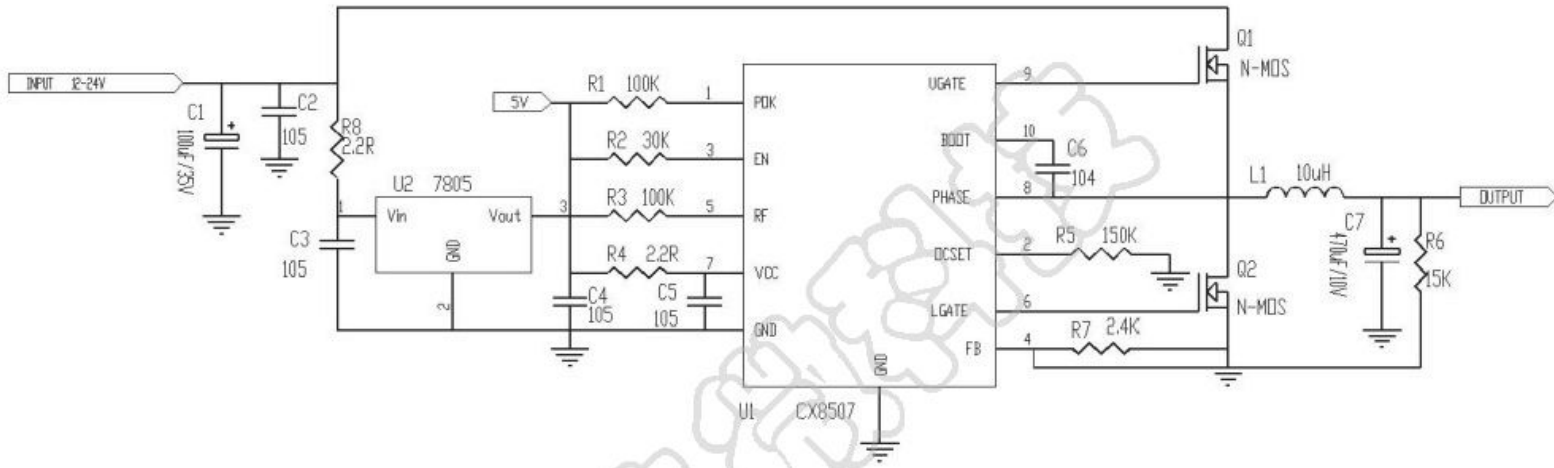
CH1:  $V_{OUT}$ , 1V/Div, DC  
 CH2:  $V_{UGATE}$ , 20V/Div, DC  
 CH3:  $V_{LGATE}$ , 5V/Div, DC  
 CH4:  $I_L$ , 20A/Div, DC  
 TIME: 1ms/Div

### Over-Voltage Protection



CH1:  $V_{OUT}$ , 1V/Div, DC  
 CH2:  $V_{UGATE}$ , 20V/Div, DC  
 CH3:  $V_{LGATE}$ , 5V/Div, DC  
 CH4:  $V_{POK}$ , 5V/Div, DC  
 TIME: 50 $\mu$ s/Div

## Typical Application Circuit



## Function Description

### Constant-On-Time PWM Controller with Input Feed-Forward

The constant-on-time control architecture is a pseudo-fixed frequency with input voltage feed-forward. This architecture relies on the output filter capacitor's effective series resistance (ESR) to act as a current-sense resistor, so the output ripple voltage provides the PWM ramp signal. In PFM operation, the high-side switch on-time controlled by the on-time generator is determined solely by a one-shot whose pulse width is inversely proportional to input voltage and directly proportional to output voltage. In PWM operation, the high-side switch on-time is determined by a switching frequency control circuit in the on-time generator block.

The switching frequency control circuit senses the switching frequency of the high-side switch and keeps regulating it at a constant frequency in PWM mode. The design improves the frequency variation and is more outstanding than a conventional constant-on-time controller, which has large switching frequency variation over input voltage, output current, and temperature. Both in PFM and PWM, the on-time generator, which senses input voltage on PHASE pin, provides very fast on-time response to input line transients.

Another one-shot sets a minimum off-time (450ns, typical). The on-time one-shot is triggered if the error comparator is high, the low-side switch current is below the current-limit threshold, and the minimum off-time one-shot has timed out.

### Pulse-Frequency Modulation (PFM)

When V<sub>RF</sub> is below the RF low threshold (0.5V, maximum), the converter is in automatic PFM/PWM operation mode. In PFM mode, an automatic switchover to pulse-frequency modulation (PFM) takes place at light loads. This switchover is affected by a comparator that truncates the low-side switch on-time at the inductor current zero crossing. This mechanism causes the threshold between PFM and PWM operation to coincide with the boundary between continuous and discontinuous inductor-current operation (also known as the critical conduction point). The on-time of PFM is given by:

$$T_{\text{ON-PFM}} = \frac{1}{F_{\text{SW}}} \times \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

Where F<sub>SW</sub> is the nominal switching frequency of the converter in PWM mode.

The load current at handoff from PFM to PWM mode is given by:

$$\begin{aligned} I_{\text{LOAD(PFM to PWM)}} &= \frac{1}{2} \times \frac{V_{\text{IN}} - V_{\text{OUT}}}{L} \times T_{\text{ON-PFM}} \\ &= \frac{V_{\text{IN}} - V_{\text{OUT}}}{2L} \times \frac{1}{F_{\text{SW}}} \times \frac{V_{\text{OUT}}}{V_{\text{IN}}} \end{aligned}$$

### Forced-PWM Mode

The RF pin should be pulled high to POK and the converter is in forced-PWM operation mode. The Forced-PWM mode disables the zero-crossing comparator, which truncates the low-side switch on-time at the inductor current zero crossing. This causes the low-side gate-drive waveform to become the complement of the high-side gate-drive waveform. This in turn causes the inductor current to reverse at light loads while U<sub>GATE</sub> maintains a duty factor of V<sub>OUT</sub>/V<sub>IN</sub>. The benefit of Forced-PWM mode is to keep the switching frequency fairly constant. The Forced-PWM mode is the most useful for reducing audio frequency noise, improving load-transient response, and providing sink-current capability for dynamic output voltage adjustment.

### Power-On-Reset

A Power-On-Reset (POR) function is designed to prevent wrong logic controls when the VCC voltage is low. The POR function continually monitors the bias supply voltage on the VCC pin if at least one of the enable pins is set high. When the rising VCC voltage reaches the rising VCC POR Threshold (4.35V, typical), the POR signal goes high and the chip initiates soft-start operations. There is almost no hysteresis to POR voltage threshold (about 100mV typical). When VCC voltage drops lower than 4.25V (typical), the POR disables the chip.

### EN Pin Control

When V<sub>EN</sub> is above the EN high threshold (1.8V, typical), the converter is enabled. When V<sub>EN</sub> is below the EN low threshold (0.5V, typical), the chip is in the shutdown and only low leakage current is taken from VCC.

### Digital Soft-Start

The CX8507 integrates digital soft-start circuits to ramp up the output voltage of the converter to the programmed regulation setpoint at a predictable slew rate. The slew rate of output voltage is internally controlled to limit the inrush current through the output capacitors during soft-start process. The figure 1 shows soft-start sequence. When the EN pin is pulled above the rising EN threshold voltage, the device initiates a soft-start process to ramp up the output voltage. The soft-start interval is 1ms (typical) and independent of the U<sub>GATE</sub>

## Function Description(Cont.)

switching frequency.

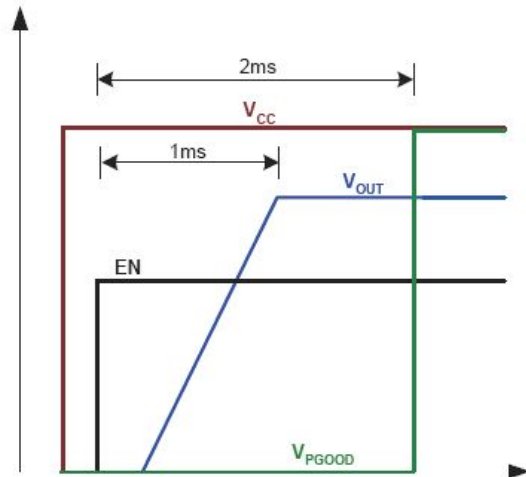


Figure 1. Soft-Start Sequence

During soft-start stage before the PGOOD pin is ready, the under-voltage protection is prohibited. The over-voltage and current-limit protection functions are enabled. If the output capacitor has residue voltage before start-up, both low-side and high-side MOSFETs are in off-state until the internal digital soft-start voltage equals to the VFB voltage. This will ensure that the output voltage starts from its existing voltage level. In the event of under-voltage, over-temperature, or shutdown, the chip enables the soft-stop function. The soft-stop function discharges the output voltage to the GND. The duration of the discharge time is 8ms.

### Power OK Indicator

The CX8507 features an open-drain POK pin to indicate output regulation status. In normal operation, when the output voltage rises 90% of its target value, the POK goes high after 63 $\mu$ s internal delay. When the output voltage outruns 70% or 125% of the target voltage, POK signal will be pulled low immediately.

Since the FB pin is used for both feedback and monitoring purposes, the output voltage deviation can be coupled directly to the FB pin by the capacitor in parallel with the voltage divider as shown in the typical applications. In order to prevent false POK from dropping, capacitors need to parallel at the output to confine the voltage deviation with severe load step transient.

### Under-Voltage Protection (UVP)

In the operational process, if a short-circuit occurs, the output voltage will drop quickly. When load current is bigger than current-limit threshold value, the output voltage will fall out of the required regulation range. The undervoltage protection circuit continually monitors the FB voltage after soft-start is completed. If a load step is strong enough to pull the output voltage lower than the undervoltage threshold, the under-voltage threshold is 70% of the nominal output voltage, the internal UVP delay counter starts to count. After 16 $\mu$ s debounce time, the device turns off both high-side and low-side MOSFET with latched and starts a soft-stop process to shut down the output gradually. Toggling enable pin to low or recycling VCC, will clear the latch and bring the chip back to operation.

### Over-Voltage Protection (OVP)

The over-voltage function monitors the output voltage by FB pin. When the FB voltage increases over 125% of the reference voltage due to the high-side MOSFET failure or for other reasons, the over-voltage protection comparator designed with a 1.5 $\mu$ s noise filter will force the lowside MOSFET gate driver fully turn on and latch high. This action actively pulls down the output voltage. This OVP scheme only clamps the voltage overshoot and does not invert the output voltage when otherwise activated with a continuously high output from low-side

### Over-Voltage Protection (OVP) (Cont.)

MOSFET driver. It's a common problem for OVP schemes with a latch. Once an over-voltage fault condition is set, it can only be reset by toggling EN, VCC power-on-reset signal.

### Current-Limit

The current-limit circuit employs a "valley" current-sensing algorithm (See Figure 2). The CX8507 uses the low-side MOSFET's RDS(ON) of the synchronous rectifier as a current-sensing element. If the magnitude of the current-sense signal at PHASE pin is above the current limit threshold, the PWM is not allowed to initiate a new cycle. The actual peak current is greater than the current limit threshold by an amount equals to the inductor ripple current. Therefore, the exact current-limit characteristic and maximum load capability are the functions of the sense resistance, inductor value, and input voltage

## Function Description(Cont.)

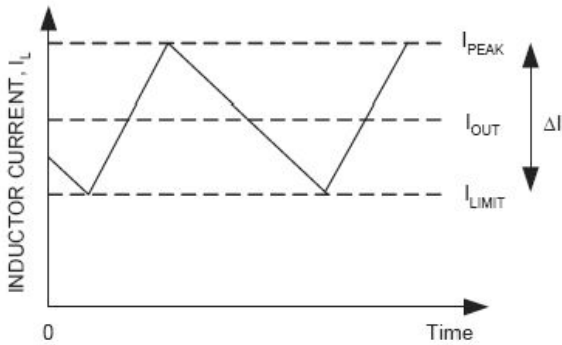


Figure 2. Current-Limit Algorithm

The PWM controller uses the low-side MOSFETs on-resistance  $R_{DS(ON)}$  to monitor the current for protection against shortened outputs. The MOSFET's  $R_{DS(ON)}$  is varied by temperature and gate to source voltage, the user should determine the maximum  $R_{DS(ON)}$  in manufacture's datasheet.

The OCSET pin can source  $10\mu A$  through an external resistor for adjusting current-limit threshold. The voltage at OCSET pin is equal to  $10\mu A \times R_{OCSET}$ . The relationship between the sampled voltage  $V_{OCSET}$  and the current-limit threshold  $I_{LIMIT}$  is given by:

$$\frac{1}{8} \times 10 \mu A \times R_{OCSET} = I_{LIMIT} \times R_{DS(ON)}$$

Where  $R_{OCSET}$  is the resistor of current-limit setting threshold.

$R_{DS(ON)}$  is the low side MOSFETs conductive resistance.  $I_{LIMIT}$  is the setting current-limit threshold.  $I_{LIMIT}$  can be expressed as  $I_{OUT}$  minus half of peak-to-peak inductor current.

The PCB layout guidelines should ensure that noise and DC errors do not corrupt the current-sense signals at PHASE. Place the hottest power MOSFETs as close to the IC as possible for best thermal coupling. When combined with the under-voltage protection circuit, this current-limit method is effective in almost every circumstance.

### Over-Temperature Protection (OTP)

When the junction temperature increases above the rising threshold temperature  $T_{OTR}$ , the IC will enter the overtemperature protection state that suspends the PWM, which forces the UGATE and LGATE gate drivers output low. The thermal sensor allows the converters to start a start-up process and regulate the output voltage again after the junction temperature cools by  $25^{\circ}C$ . The OTP is designed with a  $25^{\circ}C$  hysteresis to lower the average  $T_J$  during continuous thermal overload conditions, which increases lifetime of the CX8507

### Programming the On-Time Control and PWM Switching Frequency

The CX8507 does not use a clock signal to produce PWM. The device uses the constant-on-time control architecture to produce pseudo-fixed frequency with input voltage feed-forward. The on-time pulse width is proportional to output voltage  $V_{OUT}$  and inverses proportional to input voltage  $V_{IN}$ . The switching frequency is selectable from four preset values by a resistor connected to RF pin as shown in Table 1.

CX8507 doesn't have  $V_{IN}$  pin to calculate on-time pulse width.

Therefore, monitoring VPHASE voltage as input voltage to calculate on-time when the high-side MOSFET is turned on. And then, use the relationship between ontime and duty cycle to obtain the switching frequency.

Table 1.

Resistance $R_{RF}$ (k $\Omega$ )	Switching Frequency $F_{SW}$ (kHz)
470	290
200	340
100	380
39	430

## Application Information

### Output Voltage Setting

The output voltage is adjustable from 0.7V to 5.5V with a resistor-divider connected with FB, GND, and converter's output. Using 1% or better resistors for the resistor-divider is recommended. The output voltage is determined by:

$$V_{OUT} = 0.7 \times \left( 1 + \frac{R_{TOP}}{R_{GND}} \right)$$

Where 0.7 is the reference voltage,  $R_{TOP}$  is the resistor connected from converter's output to FB, and  $R_{GND}$  is the resistor connected from FB to GND. Suggested  $R_{GND}$  is in the range from 1k to 20k $\Omega$ . To prevent stray pickup, locate resistors  $R_{TOP}$  and  $R_{GND}$  close to CX8507

### Output Inductor Selection

The duty cycle (D) of a buck converter is the function of the input voltage and output voltage. Once an output voltage is fixed, it can be written as:

$$D = \frac{V_{OUT}}{V_{IN}}$$

The inductor value (L) determines the inductor ripple current,  $I_{RIPPLE}$ , and affects the load transient response. Higher inductor value reduces the inductor's ripple current and induces lower output ripple voltage.

The ripple current and ripple voltage can be approximated by:

$$I_{RIPPLE} = \frac{V_{IN} - V_{OUT}}{F_{SW} \times L} \times \frac{V_{OUT}}{V_{IN}}$$

Where  $F_{SW}$  is the switching frequency of the regulator. Although the inductor value and frequency are increased and the ripple current and voltage are reduced, a tradeoff exists between the inductor's ripple current and the regulator load transient response time.

A smaller inductor will give the regulator a faster load transient response at the expense of higher ripple current. Increasing the switching frequency ( $F_{SW}$ ) also reduces the ripple current and voltage, but it will increase the switching loss of the MOSFETs and the power dissipation of the converter. The maximum ripple current occurs at the maximum input voltage. A good starting point is to choose the ripple current to be approximately 30% of the maximum output current. Once the inductance value has been chosen, selecting an inductor which is capable of carrying the required peak current without going into saturation. In some types of inductors, especially core that is made of ferrite, the ripple current will increase abruptly when it saturates.

This results in a larger output ripple voltage. Besides, the inductor needs to have low DCR to reduce the loss of efficiency.

### Output Capacitor Selection

Output voltage ripple and the transient voltage deviation are factors which have to be taken into consideration when selecting an output capacitor. Higher capacitor value and lower ESR reduce the output ripple and the load transient drop. Therefore, selecting high performance low ESR capacitors is recommended for switching regulator applications. In addition to high frequency noise related to MOSFET turn-on and turnoff, the output voltage ripple includes the capacitance voltage drop  $\Delta V_{COUT}$  and ESR voltage drop  $\Delta V_{ESR}$  caused by the AC peak-to-peak inductor's current. These two voltages can be represented by:

$$\Delta V_{COUT} = \frac{I_{RIPPLE}}{8C_{OUT}F_{SW}}$$
$$\Delta V_{ESR} = I_{RIPPLE} \times R_{ESR}$$

These two components constitute a large portion of the total output voltage ripple. In some applications, multiple capacitors have to be paralleled to achieve the desired ESR value. If the output of the converter has to support another load with high pulsating current, more capacitors are needed in order to reduce the equivalent ESR and suppress the voltage ripple to a tolerable level. A small decoupling capacitor (1 $\mu$ F) in parallel for bypassing the noise is also recommended, and the voltage rating of the output capacitors are also must be considered. To support a load transient that is faster than the switching frequency, more capacitors are needed for reducing the voltage excursion during load step change. Another aspect of the capacitor selection is that the total AC current going through the capacitors has to be less than the rated RMS current specified on the capacitors in order to prevent the capacitor from over-heating.

### Input Capacitor Selection

The input capacitor is chosen based on the voltage rating and the RMS current rating. For reliable operation, selecting the capacitor voltage rating to be at least 1.3 times higher than the maximum input voltage. The maximum RMS current rating requirement is approximately  $I_{OUT}/2$ , where  $I_{OUT}$  is the load current. During power-up, the input capacitors have to handle great amount of surge current. For low-duty notebook applications, ceramic capacitor is recommended. The

## Application Information(Cont.)

capacitors must be connected between the drain of high-side MOSFET and the source of low-side MOSFET with very low-impedance PCB layout.

### MOSFET Selection

The application for a notebook battery with a maximum voltage of 24V, at least a minimum 30V MOSFETs should be used. The design has to trade off the gate charge with the  $R_{DS(ON)}$  of the MOSFET:

For the low-side MOSFET, before it is turned on, the body diode has been conducting. The low-side MOSFET driver will not charge the miller capacitor of this MOSFET. In the turning off process of the low-side MOSFET, the load current will shift to the body diode first. The high  $dv/dt$  of the phase node voltage will charge the miller capacitor through the low-side MOSFET driver sinking current path. This results in much less switching loss of the lowside MOSFETs. The duty cycle is often very small in high battery voltage applications, and the low-side MOSFET will conduct most of the switching cycle; therefore, when using smaller  $R_{DS(ON)}$  of the low-side MOSFET, the converter can reduce power loss. The gate charge for this MOSFET is usually the secondary consideration. The high-side MOSFET does not have this zero voltage switching condition; in addition, because it conducts for less time compared to the low-side MOSFET, the switching loss tends to be dominant. Priority should be given to the MOSFETs with less gate charge, so that both the gatedriver loss and switching loss will be minimized.

The selection of the N-channel power MOSFETs are determined by the  $R_{DS(ON)}$ , reversing transfer capacitance ( $C_{RSS}$ ) and maximum output current requirement.

The losses in the MOSFETs have two components: conduction loss and transition loss. For the high-side and low-side MOSFETs, the losses are approximately given by the following equations:

$$P_{\text{high-side}} = I_{\text{OUT}}^2 (1 + TC) (R_{DS(ON)}) D + (0.5) (I_{\text{OUT}}) (V_{\text{IN}}) (t_{\text{SW}}) F_{\text{SW}}$$
$$P_{\text{low-side}} = I_{\text{OUT}}^2 (1 + TC) (R_{DS(ON)}) (1 - D)$$

Where

$I_{\text{OUT}}$  is the load current

TC is the temperature dependency of  $R_{DS(ON)}$

$F_{\text{SW}}$  is the switching frequency

$t_{\text{SW}}$  is the switching interval

D is the duty cycle

Note that both MOSFETs have conduction losses while the high-side MOSFET includes an additional transition loss. The switching interval,  $t_{\text{SW}}$ , is the function of the reverse transfer capacitance  $C_{RSS}$ . The  $(1 + TC)$  term is a factor in the temperature dependency of the  $R_{DS(ON)}$  and can be extracted from the " $R_{DS(ON)}$  vs. Temperature" curve of the power MOSFET.

### Layout Consideration

In any high switching frequency converter, a correct layout is important to ensure proper operation of the regulator. With power devices switching at higher frequency, the resulting current transient will cause voltage spike across the interconnecting impedance and parasitic circuit elements. As an example, consider the turn-off transition of the PWM MOSFET. Before turn-off condition, the MOSFET is carrying the full load current. During turn-off, current stops flowing in the MOSFET and is freewheeling by the low side MOSFET and parasitic diode. Any parasitic inductance of the circuit generates a large voltage spike during the switching interval. In general, using short and wide printed circuit traces should minimize interconnecting impedances and the magnitude of voltage spike. Besides, signal and power grounds are to be kept separating and finally combined using ground plane construction or single point grounding. The best tie-point between the signal ground and the power ground is at the negative side of the output capacitor on each channel, where there is less noise. Noisy traces beneath the IC are not recommended. Below is a checklist for your layout:

- Keep the switching nodes (UGATE, LGATE, BOOT, and PHASE) away from sensitive small signal nodes since these nodes are fast moving signals. Therefore, keep traces to these nodes as short as possible and there should be no other weak signal traces in parallel with these traces on any layer.

- The signals going through these traces have both high  $dv/dt$  and high  $di/dt$  with high peak charging and discharging current. The traces from the gate drivers to the MOSFETs (UGATE and LGATE) should be short and wide.

- Place the source of the high-side MOSFET and the drain of the low-side MOSFET as close as possible. Minimizing the impedance with wide

## Application Information(Cont.)

layout plane between the two pads reduces the voltage bounce of the node. In addition, the large layout plane between the drain of the MOSFETs (VIN and PHASE nodes) can get better heat sinking.

- The GND is the current sensing circuit reference ground and also the power ground of the LGATE lowside MOSFET. On the other hand, the GND trace should be a separate trace and independently go to the source of the low-side MOSFET. Besides, the current sense resistor should be close to OCSET pin to avoid parasitic capacitor effect and noise coupling.

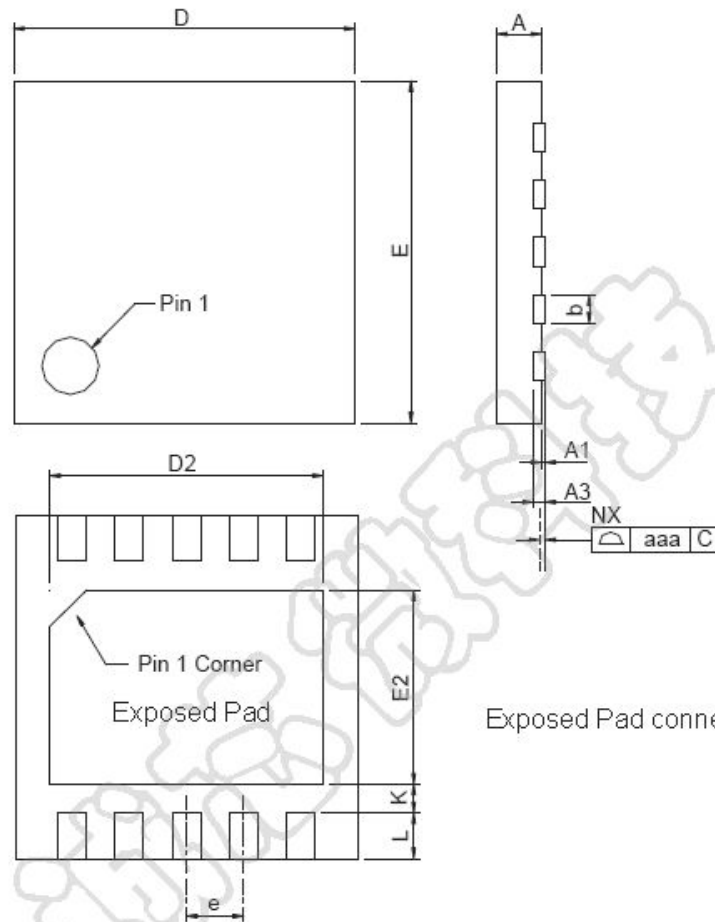
- Decoupling capacitors, the resistor-divider, and boot capacitor should be close to their pins. (For example, place the decoupling ceramic capacitor close to the drain of the high-side MOSFET as close as possible.)

- The input bulk capacitors should be close to the drain of the high-side MOSFET, and the output bulk capacitors should be close to the loads. The input capacitor's ground should be close to the grounds of the output capacitors and low-side MOSFET.

- Locate the resistor-divider close to the FB pin to minimize the high impedance trace. In addition, FB pin traces can't be close to the switching signal traces(UGATE, LGATE, BOOT, and PHASE).



TDFN3x3-10



DIMENSIONS	TDFN3x3-10			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	0.80	0.028	0.031
A1	0.00	0.05	0.000	0.002
A3	0.20 REF		0.008 REF	
b	0.18	0.30	0.007	0.012
D	2.90	3.10	0.114	0.122
D2	2.20	2.70	0.087	0.106
E	2.90	3.10	0.114	0.122
E2	1.40	1.75	0.055	0.069
e	0.50 BSC		0.016 BSC	
L	0.30	0.50	0.012	0.020
K	0.20		0.008	
aaa	0.08		0.003	